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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/723,309	11/26/2003	Christian Pacha	V0195.0004	6833	
38881	7590 06/16/2006	EXAMINER			
DICKSTEIN SHAPIRO MORIN & OSHINSKY LLP. 1177 AVENUE OF THE AMERICAS 6TH AVENUE			LAM, TUA	LAM, TUAN THIEU	
	YORK, NY 10036-1400		ART UNIT	PAPER NUMBER	
			2816		
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Please find below and/or attached an Office communication concerning this application or proceeding.

	Applicati n No.	Applicant(s)	
	10/723,309	PACHA ET AL.	
Offic Action Summary	Examin r	Art Unit	
	Tuan T. Lam	2816	
Th MAILING DATE of this c mmunication app Period f r R ply	ears on the ce ver sheet with the c	orrespondenc address	
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication.  If NO period for reply is specified above, the maximum statutory period w Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION  16(a). In no event, however, may a reply be tim  rill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	I.  lely filed  the mailing date of this communication.  D (35 U.S.C. § 133).	
Status			
Responsive to communication(s) filed on 12 Ma     This action is FINAL. 2b) ☐ This     Since this application is in condition for allowant closed in accordance with the practice under E.	action is non-final. ace except for formal matters, pro		
Disp sition of Claims			
4) ☑ Claim(s) 25-37 and 39-53 is/are pending in the 4a) Of the above claim(s) 26 and 51 is/are witho 5) ☐ Claim(s) is/are allowed. 6) ☑ Claim(s) 25,27-37,39-50,52 and 53 is/are reject 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction and/or	drawn from consideration.		
Application Papers			
9) ☐ The specification is objected to by the Examiner 10) ☑ The drawing(s) filed on 12 May 2005 is/are: a) ☐ Applicant may not request that any objection to the o Replacement drawing sheet(s) including the correction 11) ☐ The oath or declaration is objected to by the Examiner	☑ accepted or b) ☐ objected to be drawing(s) be held in abeyance. See on is required if the drawing(s) is obj	e 37 CFR 1.85(a). ected to. See 37 CFR 1.121(d).	
Priority under 35 U.S.C. § 119			
a) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of:  1. Certified copies of the priority documents 2. Certified copies of the priority documents 3. Copies of the certified copies of the priori application from the International Bureau * See the attached detailed Office action for a list of	have been received. have been received in Application ity documents have been received (PCT Rule 17.2(a)).	on No ed in this National Stage	
Attachment(s)  1) Notice of References Cited (PTO-892)  2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	. 4) Interview Summary Paper No(s)/Mail Da	(PTO-413)	
2) Notice of Dialisperson's Patent Diawing Review (P10-948)  3) Information Disclosure Statement(s) (PT0-1449 or PT0/SB/08)  Paper No(s)/Mail Date		atent Application (PTO-152)	

## **DETAILED ACTION**

This is a response to the amendment filed 5/12/2006. Claims 25, 27-37, 39-50, 52 and 53 are under examination. Claims 26 and 51 have been withdrawn from consideration.

# Claim Rejections - 35 USC § 112

- 1. The following is a quotation of the second paragraph of 35 U.S.C. 112:
  - The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.
- 2. Claims 31-32 and 53 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

In claim 31, the recitation of "the at least one third power switch transistor" in line 5 lacks proper antecedent basis. Did applicant mean second power switch transistor?

In claim 53, the recitation of "the at least one two power switch transistor" in line 17 lacks proper antecedent basis. Did applicant mean second power switch transistor?

Claim 32 is indefinite because of the technical deficiency of claim 53.

## Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

1. Claims 25, 27-37, 45-50 and 52-53 are rejected under 35 U.S.C. 102(e) as being anticipated by Matsuzaki et al. (USP 6,500,715), prior art of record. Figure 14 of Matsuzaki et al. shows a circuit arrangement comprising a flip flop (LH1 details shown in figure 8) having a plurality of storage transistors with a threshold voltage of a first value (high threshold), a first power switch transistor (MN1) having a second threshold voltage (high threshold), wherein an application of a predetermined electrical potential (CS) to the first power switch transistor gate terminal brings the circuit arrangement to an operating state (standby mode) in which if at least one supply voltage(VSS) is switched off, electric charge carriers (leakage current) contained in the circuit arrangement are prevented from discharged from the circuit arrangement, and a plurality of switching transistors (TP1-TP3), having a threshold voltage of a third value. provided between the flip flop and the first power switch transistor, for coupling the flip flop input signal (IN) into the flip flop, wherein the magnitude of the first and/or second value is greater that the magnitude of the third value (high threshold voltage is larger than the low threshold voltage), wherein each one of the terminals of the switching transistors (TP1 to TP3) has a defined electrical potential in the operating state (in the standby mode, the source, drain and gate terminals of the switching transistors have a defined electrical potential) as called for in claim 29.

Regarding claim 25, the flip flop (LH1) has two inverters.

Regarding claim 27, since the storage and the first power switching transistors have a higher threshold voltage, the thickness of the gate insulating layer of the storage transistors and the first power switch transistor is greater than the thickness of the gate insulating layer of the switching transistors.

Regarding claim 28, since the storage and the first power switching transistors have a higher threshold voltage, the channel width of the storage transistors and the first power switch transistor is less than the thickness of the gate insulating layer of the switching transistors.

Regarding claims 30 and 52, figure 14 shows a second power switch transistor (MP4, MN4) coupled to at least a portion of the switching transistors (TP1-TP3) such that in an operating state (standby mode) at least one supply voltage of the circuit arrangement is switched off, a gate terminal of each of the switching transistors coupled to the second power switch transistor has a predefined electrical potential (gate of TP1 to TP3 has a predefined potential Vdd).

Regarding claims 31-32 and 53, figure 14 shows a second power switch transistor (MP4, MN4) coupled to at least a portion of the switching transistors (TP1-TP3) such that in an operating state (standby mode) at least one supply voltage of the circuit arrangement is switched off, a source/drain terminal of each of the switching transistors coupled to the second power switch transistor has a predefined electrical potential (source of TP1 to TP3 has a predefined potential Vdd).

Regarding claim 33, figure 45 shows a pulse generator (NA1) that generates a flip flop input signal from an input signal (Ai, Aj) and from a clock signal (φ) and is coupled to the first power switch transistor (MP1) and to the switching transistors (IV1).

Regarding claims 34 and 37, figure 45 of shows the pulse generator (NA1) having transistors with low threshold voltages.

Regarding claims 35-36, figure 45 shows the subcircuit NA1 generates at least one flip flop input signal from at least one input signal Ai with a predetermined logic operation (nand logic operation).

Regarding claims 47-48, figure 45 of Matsuzaki et al. shows the protection transistors MP5, MN5 having high threshold voltage.

Regarding claims 45 and 50, figure 14 of Matsuzaki et al. shows the protection transistors MP4, MN4 having high threshold voltage.

Regarding claim 46, since the protection transistors have a higher threshold voltage, the thickness of the gate insulating layer of the protection are greater than the thickness of the gate insulating layer of the switching transistors.

Regarding claim 49, in a first operating state, power switch MN1 switches off power supply to the switching transistors, the same control signal CS also electrically decouple the flip flop form the switching transistors, in a second operating state, the power switch MN1 connecting the power supply to the switching transistors, the protection circuit electrically couples the flip flop to the switching transistors.

## Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. Claims 39-42 are rejected under 35 U.S.C. 103(a) as being unpatentable over Matsuzaki et al. (USP 6,500,715) in view of Sani et al. (USP 6,794,914).

Figure 14 of Matsuzaki et al. shows a circuit arrangement comprising a flip flop (LH1) details shown in figure 8) having a plurality of storage transistors with a threshold voltage of a first value (high threshold), a first power switch transistor (MN1) having a second threshold voltage (high threshold), wherein an application of a predetermined electrical potential (CS) to the first power switch transistor gate terminal brings the circuit arrangement to an operating state (standby mode) in which if at least one supply voltage(VSS) is switched off, electric charge carriers (leakage current) contained in the circuit arrangement are prevented from discharged from the circuit arrangement, and a plurality of switching transistors (TP1-TP3), having a threshold voltage of a third value, provided between the flip flop and the first power switch transistor, for coupling the flip flop input signal (IN) into the flip flop, wherein the magnitude of the first and/or second value is greater that the magnitude of the third value (high threshold voltage is larger than the low threshold voltage), wherein each one of the terminals of the switching transistors (TP1 to TP3) has a defined electrical potential in the operating state (in the standby mode, the source, drain and gate terminals of the switching transistors have a defined electrical potential).

Matsuzaki et al. does not disclose a test circuit coupled to the flip flop for testing the functionality of the flip flop as called for in claim 39. Sani et al. shows a flip flop having a test circuit (310 of figure 3) to test and to enhance the reliability of the flip flop. Therefore, it would have been obvious to a person skilled in the art at the time the invention was made to include Sani et al.'s test circuit in the circuit arrangement of Matsuzaki et al. for purpose of enhancing the reliability of the flip flop.

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Regarding claim 40, the combination of Matsuzaki et al. and Sani et al. show the test circuit comprising a test input signal (Sin), output components (output of the flip flop) that reads a test output signal of the flip flop.

Regarding claim 41, the combination of Matsuzaki et al. and Sani et al. show the test circuit comprising a plurality of transistors (322, 324) having a high threshold voltage.

Regarding claim 42, since test transistors have a higher threshold voltage than the threshold voltage of the switching transistors, the thickness of the gate insulating layer of the test transistors are greater than the thickness of the gate insulating layer of the switching transistors.

4. Claims 43-44 are rejected under 35 U.S.C. 103(a) as being unpatentable over Matsuzaki et al. (USP 6,500,715) in view of Sani et al. (USP 6,794,914).

Figure 14 of Matsuzaki et al. shows a circuit arrangement comprising a flip flop (LH1 details shown in figure 8) having a plurality of storage transistors with a threshold voltage of a first value (high threshold), a first power switch transistor (MN1) having a second threshold voltage (high threshold), wherein an application of a predetermined electrical potential (CS) to the first power switch transistor gate terminal brings the circuit arrangement to an operating state (standby mode) in which if at least one supply voltage(VSS) is switched off, electric charge carriers (leakage current) contained in the circuit arrangement are prevented from discharged from the circuit arrangement, and a plurality of switching transistors (TP1-TP3), having a threshold voltage of a third value, provided between the flip flop and the first power switch transistor, for coupling the flip flop input signal (IN) into the flip flop, wherein the magnitude of the first and/or second value is greater that the magnitude of the third value (high threshold voltage is larger than the low threshold voltage), wherein each one of the terminals of the

switching transistors (TP1 to TP3) has a defined electrical potential in the operating state (in the standby mode, the source, drain and gate terminals of the switching transistors have a defined electrical potential).

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Matsuzaki et al. does not disclose test transistors, coupled to the flip flop, having a gate thickness greater than the gate thickness of the transistors of the pulse generator as called for in claims 43 and 44. Sani et al. shows a flip flop having a test circuit (310 of figure 3) to test and to enhance the reliability of the flip flop. Therefore, it would have been obvious to a person skilled in the art at the time the invention was made to include Sani et al.'s test circuit in the circuit arrangement of Matsuzaki et al. for purpose of enhancing the reliability of the flip flop. Further, since test transistors have a higher threshold voltage than the threshold voltage of the pulse generator's transistors, the thickness of the gate insulating layer of the test transistors are greater than the thickness of the gate insulating layer of the pulse generator's transistors.

## Response to Arguments

5. Applicant's arguments filed 5/12/2006 have been fully considered but they are not persuasive.

Applicant argues that Matsuzaki et al. fails to disclose "the magnitude of the first and/or second value is greater than the magnitude of the third value" is not persuasive. Figure 14 clearly discloses the power switch (MN1) and the transistors within the latch LH1 are thick film MOS transistors. The switching transistors (TP1 to TP3) are thin film MOS transistors. Column 20, lines 60-64 further teaches that thick film MOS transistors have threshold voltage of 0.5 volt and thin film transistors have threshold voltage of 0.1 volts. Therefore, the limitations of "the

magnitude of the first and/or second value is greater than the magnitude of the third value" are fully met.

## Conclusion

6. THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Tuan T. Lam whose telephone number is 571-272-1744. The examiner can normally be reached on Monday to Friday (7:30 am to 6:00pm).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, TIMOTHY P. CALLAHAN can be reached on 571-272-1740. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Tuan T. Lam Primary Examiner Art Unit 2816

6/13/2006